# MOSFET – Power, Single, N-Channel, SO-8FL 30 V, 57 A

### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

# **Applications**

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

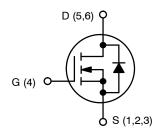
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	30	V
Gate-to-Source Vol	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>θJA</sub> (Note 1) Steady		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι <sub>D</sub>	13.1 9.5	А
State	1				
Power Dissipation R <sub>θJA</sub> (Note 1)		$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	$P_D$	2.17 1.13	W
Continuous Drain	-	T <sub>A</sub> = 25°C	I <sub>D</sub>	19.9	Α
Current $R_{\theta JA}$ – t = 10 sec		T <sub>A</sub> = 85°C		14.4	
Power Dissipation $R_{\theta JA} t \leq 10 \text{ sec}$	Steady	T <sub>A</sub> = 25°C	$P_{D}$	5	W
,	State	T <sub>A</sub> = 85°C		2.6	
Current Pare		$T_A = 25^{\circ}C$	I <sub>D</sub>	8.3	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C		6	
Power Dissipation	1	T <sub>A</sub> = 25°C	$P_{D}$	0.87	W
R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C		0.45	
Continuous Drain		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	57	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		41	
Power Dissipation	1	T <sub>C</sub> = 25°C	$P_{D}$	41.7	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		21.7	
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	171	Α
Operating Junction a Temperature	Operating Junction and Storage Temperature			-55 to +150	°C
Source Current (Boo	Source Current (Body Diode)			35	Α
Drain to Source dV/d	Drain to Source dV/dt			6	V/ns



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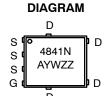
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	7.0 mΩ @ 10 V	F7 A
30 V	11.4 mΩ @ 4.5 V	57 A



**N-CHANNEL MOSFET** 



# SO-8 FLAT LEA CASE 488AA STYLE 1



**MARKING** 

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4841NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4841NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 24 V, $V_{GS}$ = 10 V, $I_L$ = 19 $A_{pk}$ , L = 1.0 mH, $R_G$ = 25 $\Omega$ )	EAS	180	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	57.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	143.4	*C/VV
Junction-to-Ambient - t = 10 sec	$R_{ hetaJA}$	25	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

# FLECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				ı		1	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				25		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			1	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V to 11.5 V V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		4.7	7.0	mΩ
			I <sub>D</sub> = 15 A		4.6		
			I <sub>D</sub> = 30 A		9.2	11.4	
			I <sub>D</sub> = 15 A		8.5		
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			16		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1436		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 12 V			348		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				177		
Total Gate Charge	Q <sub>G(TOT)</sub>				11.5	17	
Threshold Gate Charge	Q <sub>G(TH)</sub>	\\	IE \		2.0		nC
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 3.5 \text{ V}$	15 V; ID = 30 A		5.0		
Gate-to-Drain Charge	$Q_{GD}$	1			5.1		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 11.5 \text{ V, V}$ $I_{D} = 30$			25.4		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t <sub>d(ON)</sub>				13.5		
	1	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 15 \text{ A},$		l e			1
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 1$	5 V, I <sub>D</sub> = 15 A.		66.5		ns

- 3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 4. Switching characteristics are independent of operating junction temperatures.

7.5

Fall Time

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)				•		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			8.1		
Rise Time	t <sub>r</sub>				24.2		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 A, R_C$	$_{3}$ = 3.0 $\Omega$		22.8		ns
Fall Time	t <sub>f</sub>	1			5.7		1
DRAIN-SOURCE DIODE CHARACTI	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$		0.9	1.2	\ /	
			T <sub>J</sub> = 125°C		0.8		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/μs, I <sub>S</sub> = 30 A			20.5		ns
Charge Time	t <sub>a</sub>				11.6		
Discharge Time	t <sub>b</sub>				8.9		
Reverse Recovery Charge	$Q_{RR}$				10.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				0.93		nΗ
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.005		
Gate Inductance	L <sub>G</sub>				1.84		
Gate Resistance	$R_{G}$				3.2		Ω

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

### **TYPICAL PERFORMANCE CURVES**

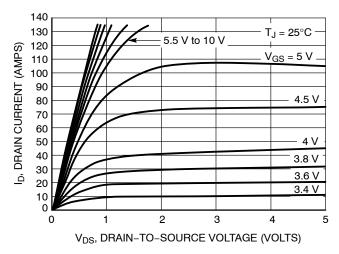


Figure 1. On-Region Characteristics

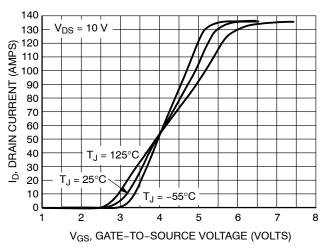


Figure 2. Transfer Characteristics

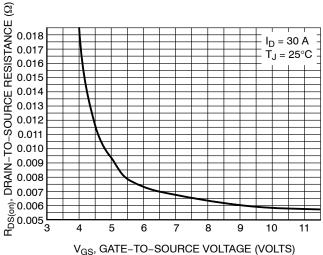


Figure 3. On-Resistance vs. Gate-to-Source Voltage

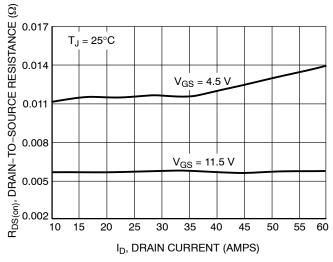


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

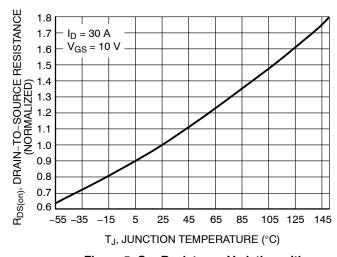


Figure 5. On–Resistance Variation with Temperature

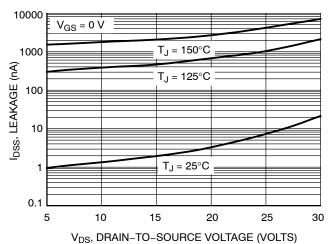
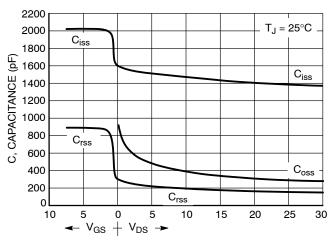


Figure 6. Drain-to-Source Leakage Current vs. Voltage

### **TYPICAL PERFORMANCE CURVES**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

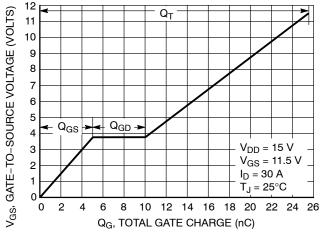


Figure 8. Gate-To-Source and Drain-To-Source
Voltage vs. Total Charge



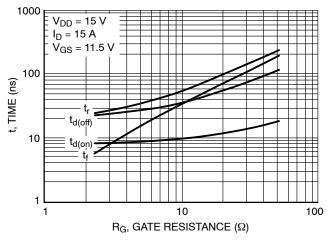


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

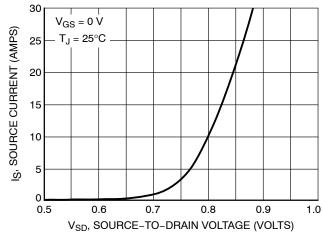


Figure 10. Diode Forward Voltage vs. Current

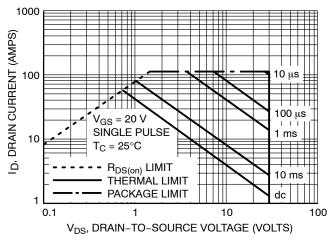


Figure 11. Maximum Rated Forward Biased Safe Operating Area

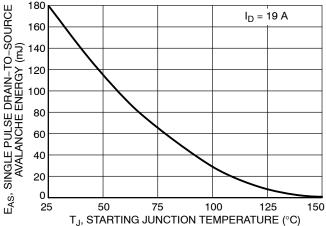


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

# **TYPICAL PERFORMANCE CURVES**

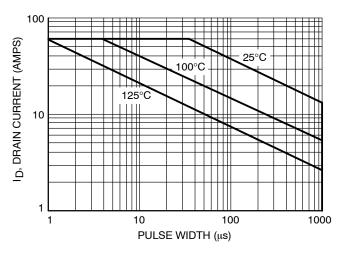


Figure 13. EAS vs. Pulse Width

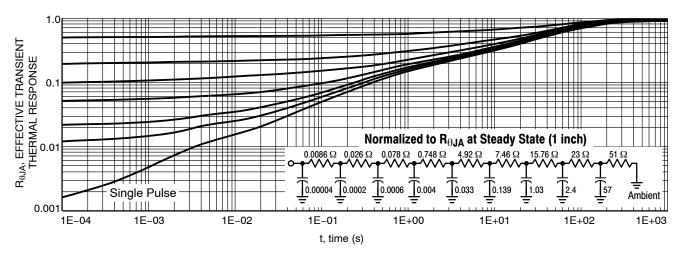


Figure 14. FET Thermal Response





0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N** 

**DATE 25 JUN 2018** 

### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	)		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	(	0.125 RE	F		
М	3.00	3.40	3.80		
θ	0 °		12 °		

### **GENERIC MARKING DIAGRAM\***

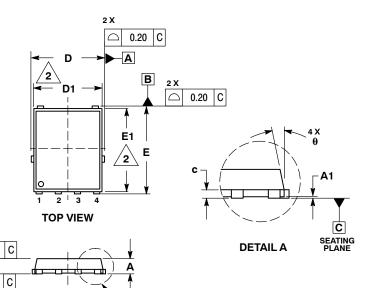


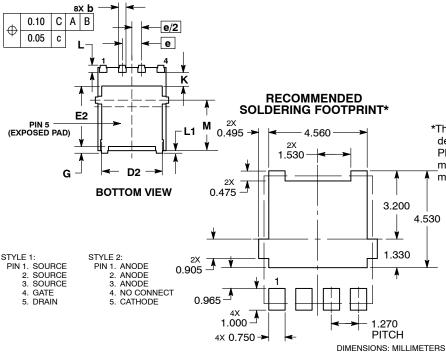
XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week = Lot Traceability ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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